

Search Notes



Application/Control No.

10/669,144

Examiner

Mark K. Han

Applicant(s)/Patent under Reexamination

TROCKI ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	93.01	3/20/2006	mlh
	118		
	121		
	131		
	152		
	154		
	181		
	187		
	218		
	228		
	533		
	534		
	535		
600	431		
	432		
128	dig. 1		
	dig.12		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST text search	3/20/2006	mlh
Inventor name search	3/20/2006	mlh